

**Search Notes**

Application/Control No.

10/707,518

Examiner

Matthew G. Kayrish

Applicant(s)/Patent under  
Reexamination

CHEN ET AL.

Art Unit

2653

**SEARCHED**

Class	Subclass	Date	Examiner
720	610	11/8/2005	MK
720	610	11/15/2005	MK

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
East (USPG-PUB, USPAT, USOCR) (See Attached Search Notes)	11/8/2005	MK
East (USPG-PUB, USPAT, USOCR) (See Attached Search Notes)	11/9/2005	MK
East (USPG-PUB, USPAT, USOCR) (See Attached Search Notes)	11/10/2005	MK
East (USPG-PUB, USPAT, USOCR) (See Attached Search Notes)	11/14/2005	MK
East (USPG-PUB, USPAT, USOCR) (See Attached Search Notes)	11/15/2005	MK